

<b>Notice of References Cited</b>	Application/Control No. 09/942,905	Applicant(s)/Patent Under Reexamination IMAICHI ET AL.	
	Examiner Anh Ly	Art Unit 2162	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0149719	07-2006	Harris, Larry R.	707/003
*	B	US-2005/0108223	05-2005	Silverbrook et al.	707/003
*	C	US-2004/0122656	06-2004	Abir, Eli	704/004
*	D	US-5,659,732	08-1997	Kirsch, Steven T.	707/5
*	E	US-2002/0184186	12-2002	Imaichi et al.	707/1
*	F	US-2002/0169771	11-2002	Melmon et al.	707/5
*	G	US-2002/0143758	10-2002	Aref, Walid G.	707/4
*	H	US-2002/0099685	07-2002	Takano et al.	707/1
*	I	US-6,484,162	11-2002	Edlund et al.	707/3
*	J	US-6,078,917	06-2000	Paulsen et al.	707/6
*	K	US-6,041,326	03-2000	Amro et al.	707/10
*	L	US-6,006,217	12-1999	Lumsden, Mark W.	707/2
*	M	US-2003/0220916	11-2003	Imaichi et al.	707/3

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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